## FDS6688

FAIRCHILD SEMICONDUCTOR

### 30V N-Channel PowerTrench<sup>®</sup> MOSFET

### **General Description**

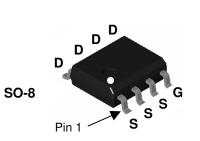
This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for "low side" synchronous rectifier operation, providing an extremely low  $R_{\text{DS}(\text{ON})}$  in a small package.

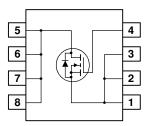
### Applications

• DC/DC converter

### Features

- 16 A, 30 V.  $R_{DS(ON)} = 6 \ m\Omega @ V_{GS} = 10 \ V$  $R_{DS(ON)} = 7 \ m\Omega @ V_{GS} = 4.5 \ V$
- Ultra-low gate charge (40 nC typical)
- High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}$
- High power and current handling capability



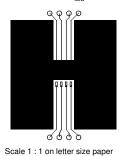


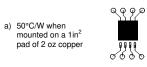
### Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter			Ratings	Units	
V <sub>DSS</sub>	Drain-Sourc	e Voltage		30		
V <sub>GSS</sub>	Gate-Sourc	e Voltage		±20	V	
ID	Drain Curre	nt – Continuous	(Note 1a)	16	A	
		– Pulsed		50		
PD	Power Dissipation for Single Operation		ON (Note 1a)	2.5	W	
			(Note 1b)	1.4		
			(Note 1c)	1.2		
T <sub>J</sub> , T <sub>STG</sub>	Operating a	nd Storage Junction Terr	nperature Range	-55 to +175	°C	
Therma	I Charac	teristics				
$R_{\theta JA}$	Thermal Re	sistance, Junction-to-Am	bient (Note 1a)	50	°C/W	
R <sub>0JA</sub>	Thermal Re	hermal Resistance, Junction-to-Ambient		125	°C/W	
R <sub>eJC</sub>	Thermal Resistance, Junction-to-Case		Se (Note 1)	25	°C/W	
Packag	e Markin	g and Ordering	Information			
Device Marking		Device	Reel Size	Tape width	Quantity	
FDS6688		FDS6688	13"	12mm	2500 units	

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics			I	1	1
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 V$ , $I_D = 250 \mu A$	30			V
<u>ΔBVdss</u> ΔTj	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$ , Referenced to $25^{\circ}\text{C}$		21		mV/°C
IDSS	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 24 \text{ V}, \qquad V_{\text{GS}} = 0 \text{ V}$			10	μA
I <sub>GSS</sub>	Gate-Body Leakage				±100	nA
On Char	acteristics (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, \qquad I_{\text{D}} = 250 \ \mu\text{A}$	1	1.8	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$ , Referenced to $25^{\circ}\text{C}$		-6		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$ \begin{array}{ll} V_{GS} = 10 \ V, & I_D = 16 \ A \\ V_{GS} = 4.5 \ V, & I_D = 15 \ A \\ V_{GS} = 10 \ V, & I_D = 16 \ A, \ T_J = 125^\circ C \end{array} $		4.5 5.2 6.2	6 7 9	mΩ
I <sub>D(on)</sub>	On-State Drain Current	$V_{\text{GS}} = 10 \text{ V}, \qquad V_{\text{DS}} = 5 \text{ V}$	50			Α
<b>g</b> fs	Forward Transconductance	$V_{\text{DS}} = 5 \text{ V}, \qquad I_{\text{D}} = 16 \text{ A}$		84		S
Dynamic	c Characteristics					
Ciss	Input Capacitance	$V_{DS} = 15 V$ , $V_{GS} = 0 V$ ,		3888		pF
Coss	Output Capacitance	f = 1.0 MHz		931		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			401		pF
R <sub>G</sub>	Gate Resistance	$V_{GS} = 15 \text{ mV},  f = 1.0 \text{ MHz}$		1.3		Ω
Switchir	ng Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{\text{DD}} = 15 \text{ V}, \qquad I_{\text{D}} = 1 \text{ A},$		14	25	ns
t <sub>r</sub>	Turn–On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		11	20	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			69	110	ns
t <sub>f</sub>	Turn-Off Fall Time			32	51	ns
Qg	Total Gate Charge	$V_{DS} = 15 V$ , $I_{D} = 16 A$ ,		40	56	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS} = 5 V$		11		nC
Q <sub>gd</sub>	Gate-Drain Charge			15		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
ls	Maximum Continuous Drain-Source	e Diode Forward Current			2.1	Α
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \ V,  I_S = 2.1 \ A  (Note 2)$		0.7	1.2	V
t <sub>rr</sub>	Diode Reverse Recovery Time	$I_F = 16 \text{ A}, d_{iF}/d_t = 100 \text{ A}/\mu\text{s}$		38		nS
Q <sub>rr</sub>	Diode Reverse Recovery Charge			53		nC





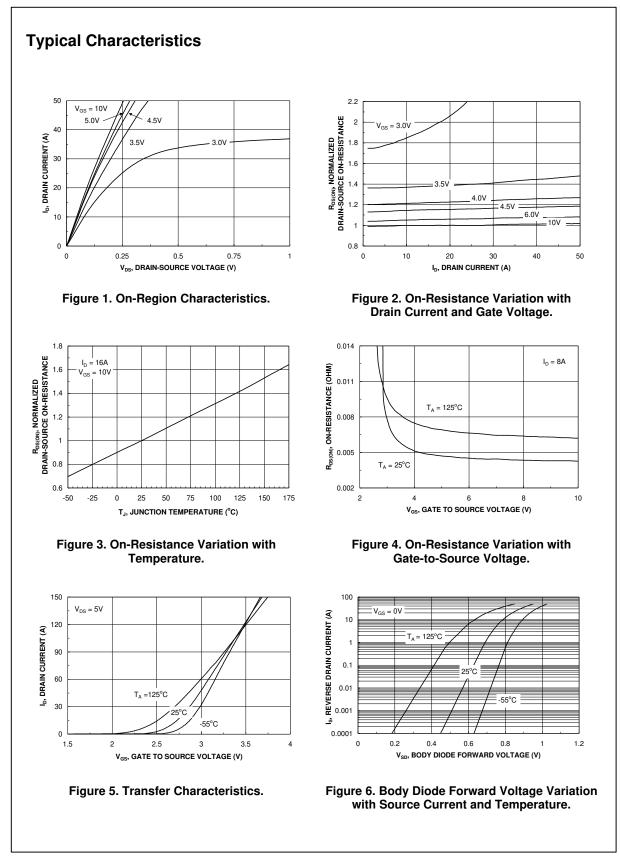
b) 105°C/W when mounted on a .04 in<sup>2</sup> pad of 2 oz copper

c) 125°C/W when mounted on a minimum pad.

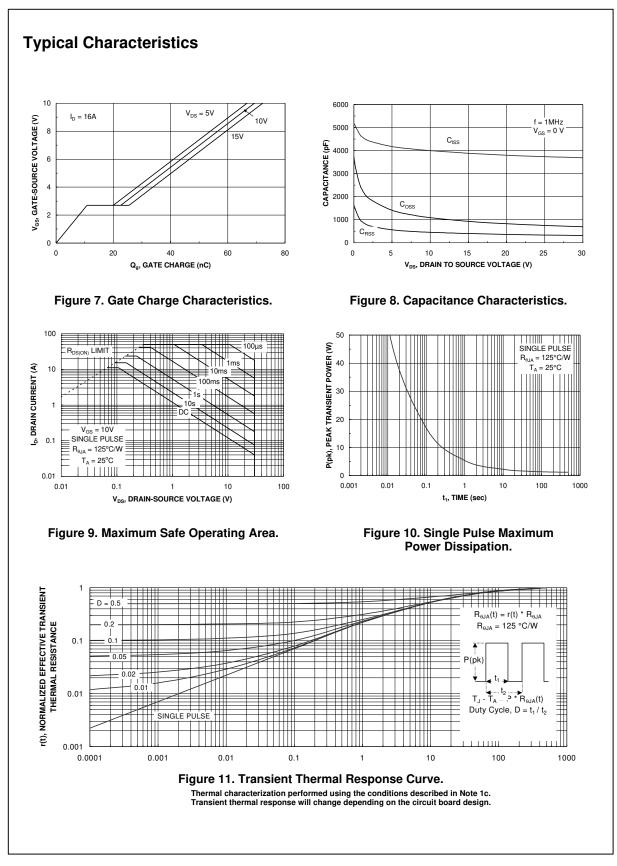
2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

FDS6688 Rev D(W)

FDS6688



FDS6688



# FDS6688

FDS6688 Rev D(W)

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